

TCAD for electronic devices part 3

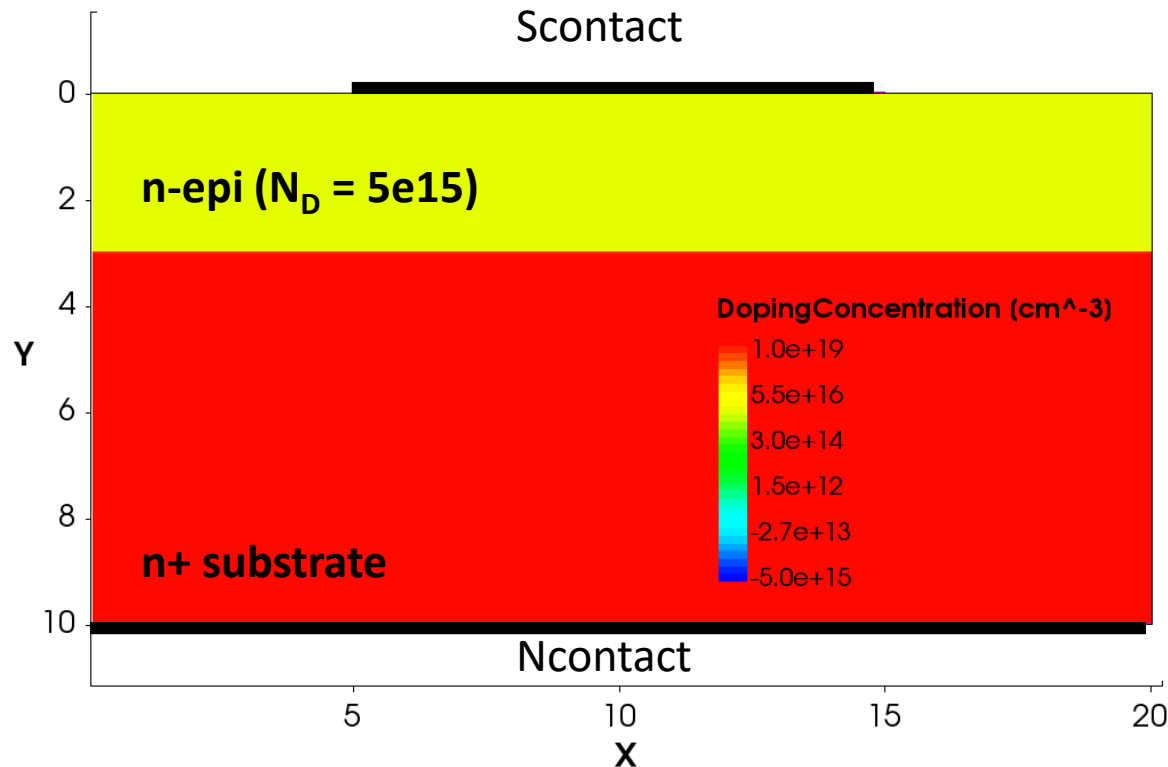
Microelectronics devices, sensors and
MEMS

Academic Year 2023/2024

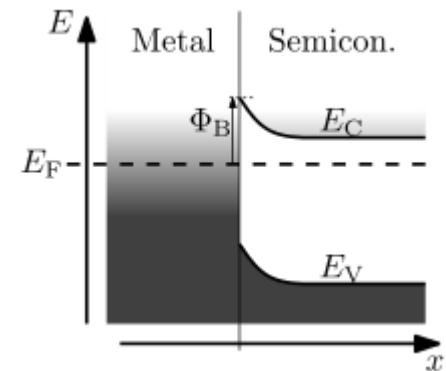
Lucio Pancheri

lucio.pancheri@unitn.it

Example 1. Schottky diode



Parameter:
Barrier potential
(**barrier** in sdevice
command files)

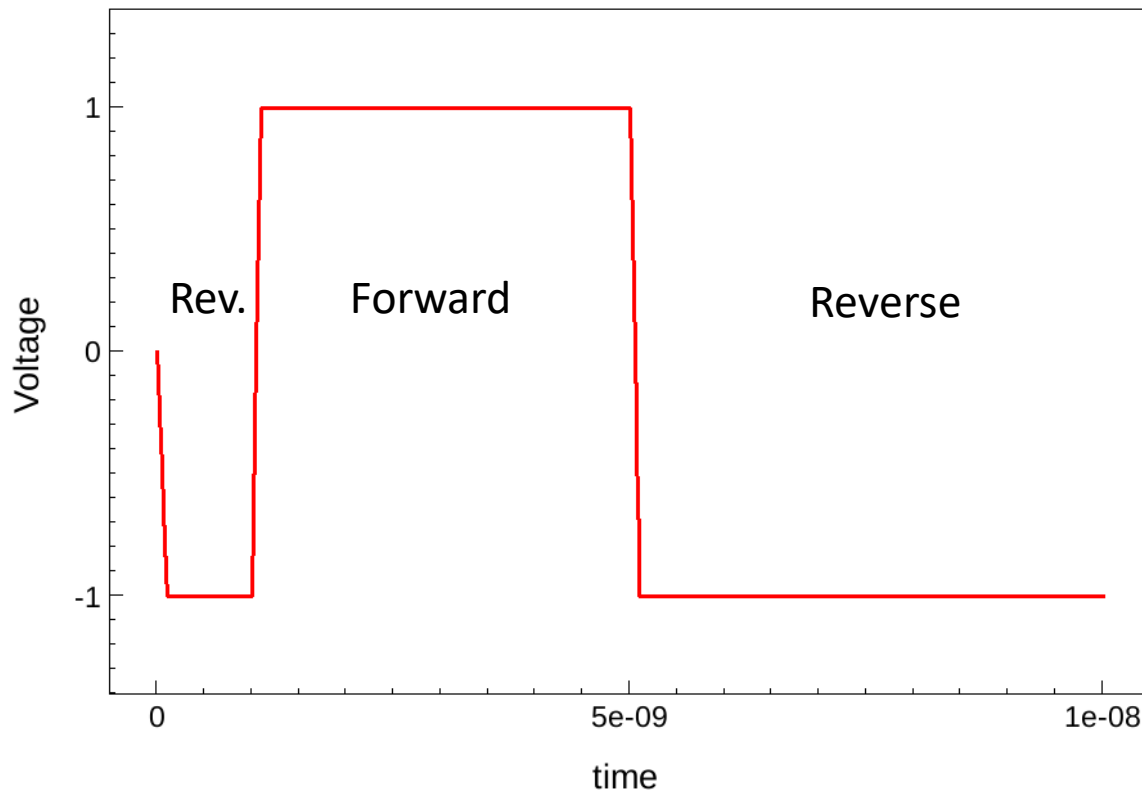


Files: `P3EX1_SchottkyDiode_sde.txt`
`P3EX1_SchottkyDiode_sdevice.txt`
`P3EX1_SchottkyDiode_sdevice2.txt`
`P3EX1_SchottkyDiode_sdevice3.txt`

Device structure
IV curve in forward bias
IV curve in reverse bias
transient simulation (switching)

Example 1. Transient simulation

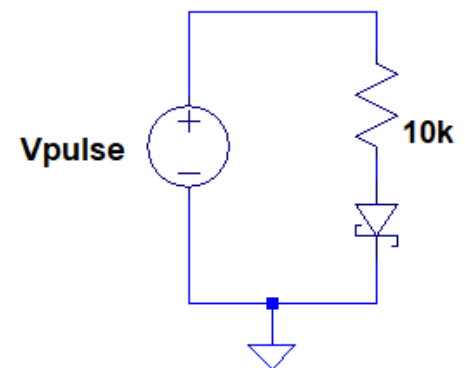
Applied Anode voltage vs. time







Series resistance:
10 kOhm

Equilibrium cap.
< 40 fF

RC time constant < 0.4ns



Example 1. Simulation setup

Project		Scheduler					
							
	SDE		SDEVICE		SDEVICE		SDEVICE
			barrier				
1	--	--	0.5	--	--	--	--
2	--	--	0.7	--	--	--	--

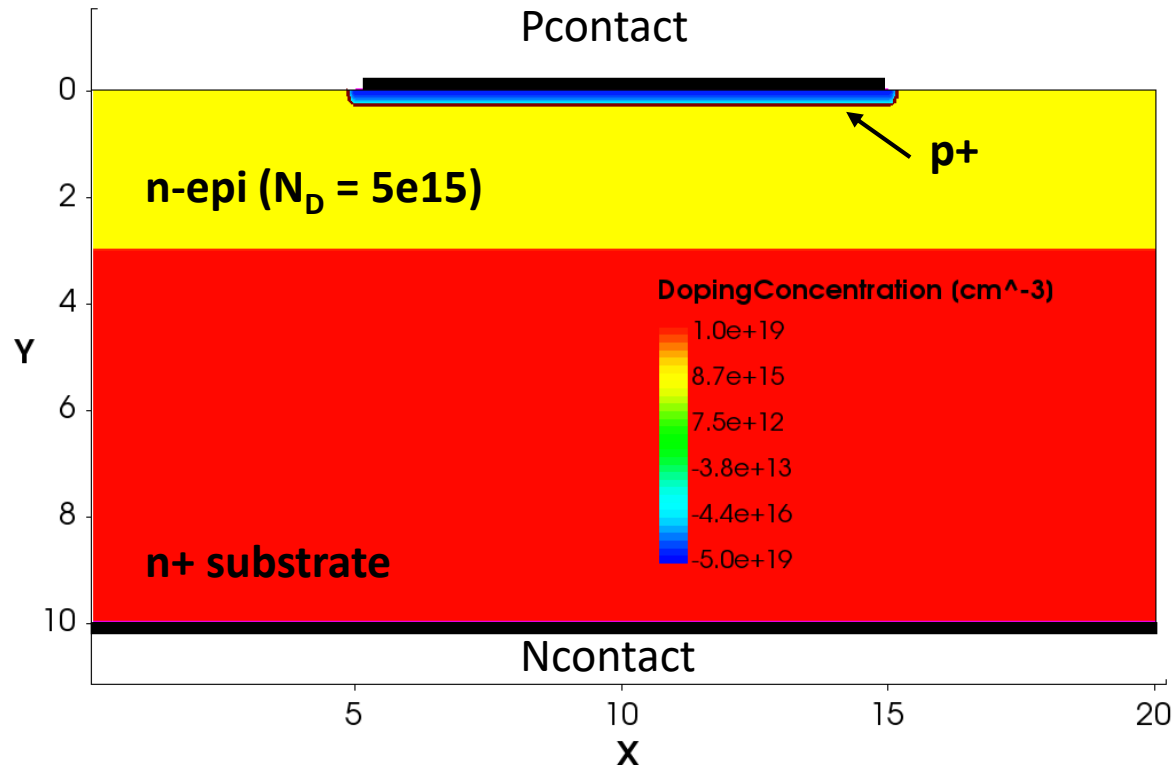
Parameters: barrier – only 2 values.

0.5V: metal = Titanium

0.7V: metal = Aluminum

The 3 different simulations (IV forward, IV reverse and transient switching) are included in the same project

Example 2. PN diode



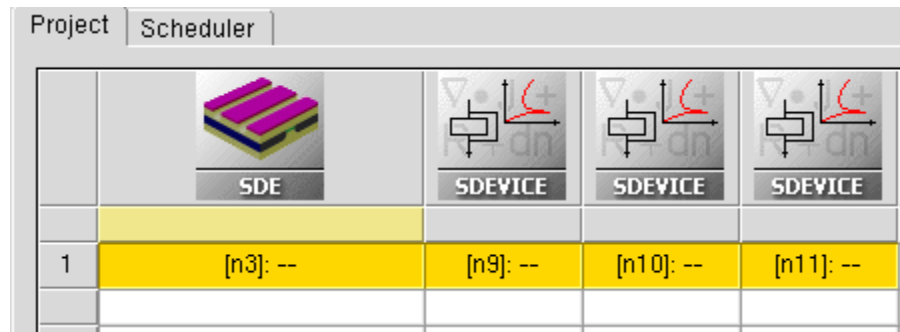
Goal: compare
PN junction diode with
Schottky diode

Files: `P3EX2_PNDiode_sde.txt`
`P3EX2_PNDiode_sdevice.txt`
`P3EX2_PNDiode_sdevice2.txt`
`P3EX2_PNDiode_sdevice3.txt`

Device structure
IV curve in forward bias
IV curve in reverse bias
transient simulation (switching)

Example 2. Simulation setup

Create a new project! (Both Schottky and pn junction projects are needed for the comparison)





The 3 different simulations (IV forward, IV reverse and transient switching) are included in the same project

Plot PNDiode IV curves in the same graph with Schottky diode IV curves

Example 3: PN diode as temperature sensor

Sentaurus Workbench setup

Project		Scheduler	
			No Variables
	SDE	SDEVICE	
			temp
1	[n5]: --	[n6]: --	[n2]: 280
2			[n7]: 290
3			[n8]: 300
4			[n9]: 310
5			[n10]: 320

Define parameter **@temp@** in command file

```
Physics{
    Temperature = @temp@
    Recombination(SRH( DopingDep ) )
}
```

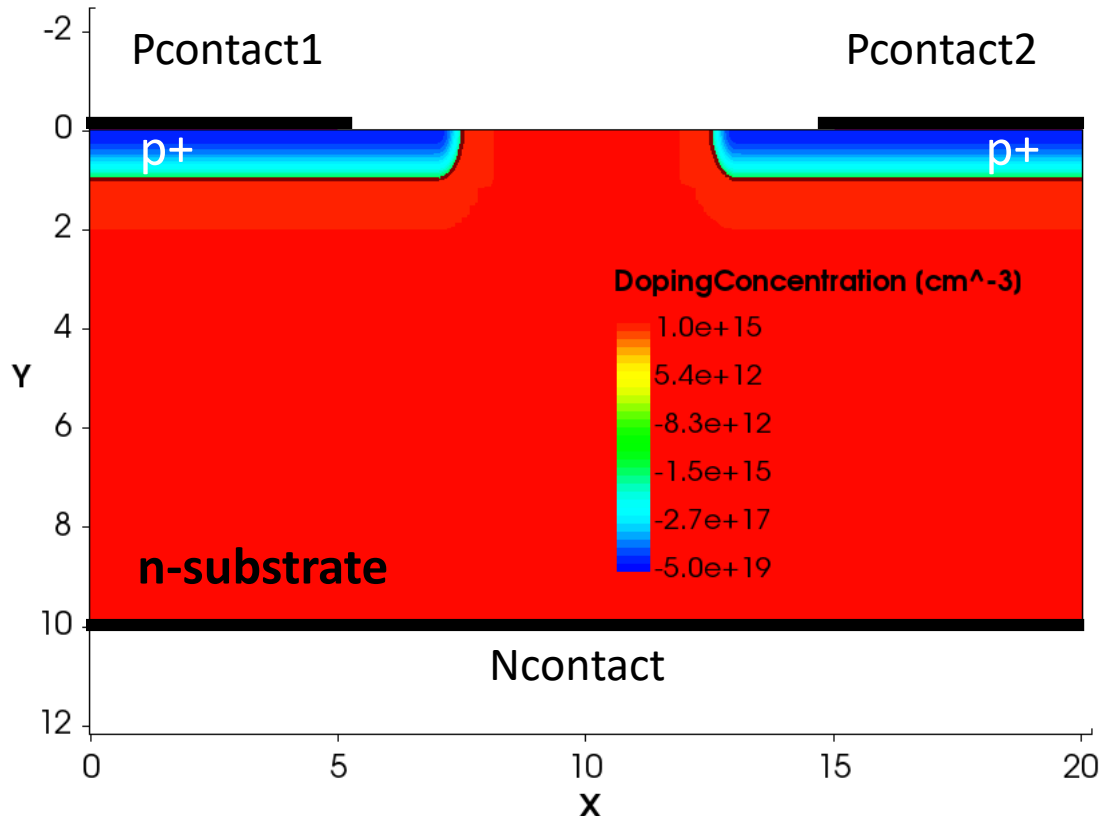
Plot the 5 IV curves in the same File and observe the temperature dependence

$$I_D \cong I_S e^{V_D/kT} \quad \longrightarrow \quad V_D \cong kT \ln \left(\frac{I_D}{I_S} \right)$$

Files: **P3EX2_PNDiode_sde.txt**
 P3EX2_PNDiode_sdevice.txt

Device structure
 IV curve in forward bias

Example 4. Punch Through



Simulate I-V curves with:

$V(\text{Ncontact}) = 0$

$V(\text{Pcontact1}) = 0$

$V(\text{Pcontact2}) = 0 \rightarrow -100$

Check the potential profile
at the cutline $Y = 0.2\mu\text{m}$ for
different applied voltages:
-10, -20 and -40V

Files: `P3EX4_PunchThrough_sde.txt`
`P3EX4_PunchThrough_sdevice.txt`

Data extraction and comparison

Shared spreadsheet:

https://docs.google.com/spreadsheets/d/1mpnvX-uLPZhbd6l7KkV_IFlfQcToHZGJy-TUE8eNIYM/edit?usp=sharing

Insert in the shared spreadsheet the following values, estimated from the simulations (alone or in groups of 2 students):

- Ex. 1 and 2: **Forward voltage** for a current of $1\mu\text{A}$
- Ex. 1 and 2: **Reverse current** at $V_R=5\text{V}$
- Ex. 1 and 2: **Negative current peak** at switch off
- Ex. 3: **Forward voltage** for a current of 1nA at the 5 different temperatures
- Ex. 4: **Pcontact1 current** at -20V and -40V